PNZ335 (PN335)

Silicon planar type

For optical control systems

■ Features

- Flat side-view type package
- High coupling capabillity suitable for plastic fiber
- High quantum efficiency
- High-speed response

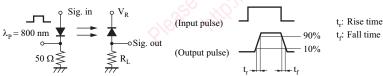
■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit
Reverse voltage	V _R	30	V
Power dissipation	P_{D}	100	mW
Operating ambient temperature	T _{opr}	-25 to +85	°C
Storage temperature	T _{stg}	-30 to +100	°C

■ Electrical-Optical Characteristics $T_a = 25$ °C±3°C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Photocurrent *1	$I_{\rm L}$	$V_R = 10 \text{ V}, L = 1000 \text{ lx}$	5.0	8.0	ijo).	μΑ
Drain current	I_{D}	$V_R = 10 \text{ V}$	30	0.1	10	nA
Terminal capacitance	C _t	$V_R = 10 \text{ V}, \text{ f} = 1 \text{ MHz}$		6	(SU)	pF
Peak sensitivity wavelength	λ_{PD}	$V_R = 10 \text{ V}$	S XC	850	3,	nm
Half-power angle	θ	The angle when the photocurrent is halved		70		0
Rise time *2	t _r	V 10 V P 50 O	100	2		ns
Fall time *2	t_{f}	$V_{\rm R} = 10 \text{ V}, R_{\rm L} = 50 \Omega$	50	2		ns

- Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.
 - 2. Spectral sensitivity characteristics: Sensitivity for wave length over 400 nm maximum sensitivity ratio is 100%.
 - 3. This device is designed by disregarding radiation.
 - 4. *1:Source: Tungsten lamp (color temperature 2 856K)
 - *2: Switching time measurement circuit

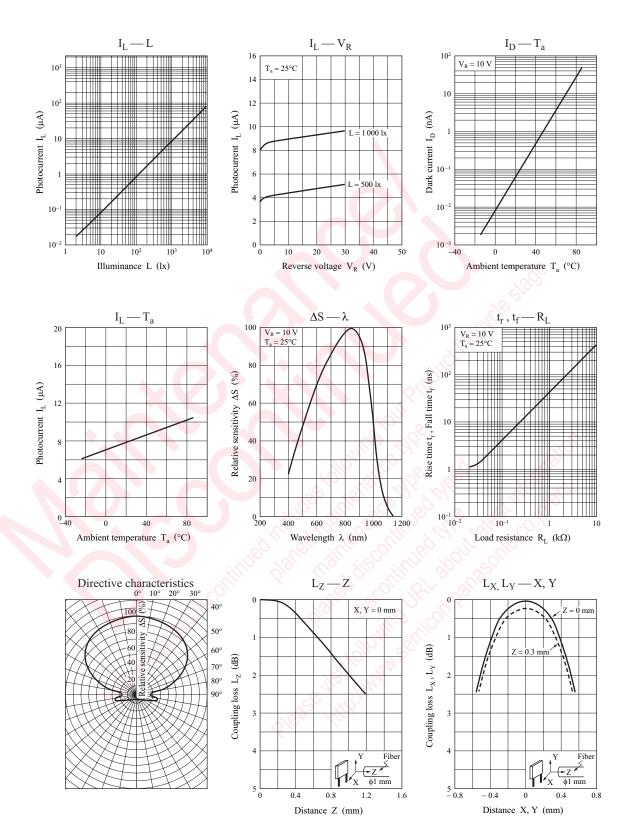


Note) The part number in the parenthesis shows conventional part number.

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PNZ335

Panasonic

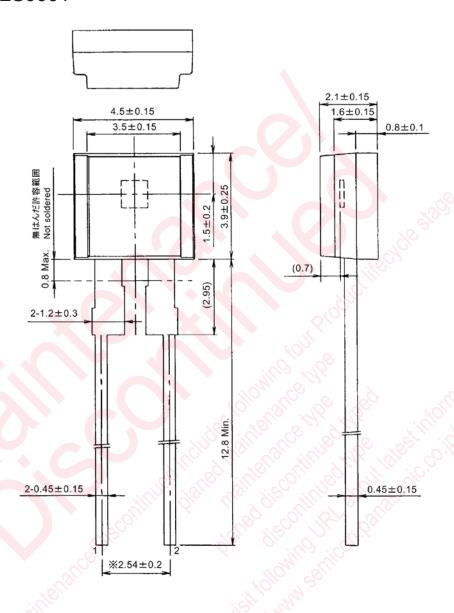


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Panasonic PNZ335

■ Package (Unit: mm)

LPTFSN2S0001



- Pin name
 - 1: Anode
 - 2: Cathode

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